Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10813818	WANG ET AL.

ExaminerArt UnitHung, Yubin2624

SEARCHED

Class	Subclass	Date	Examiner	
382	173, 176	2/21/09	YH	
707	2-4, 104.1	2/21/09	YH	
715	501.1, 513	2/21/09	YH	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	2/21/09	YH		
Inventor/assignee search (EAST, eDAN)	2/21/09	YH		
ACM	12/21/07	YH		
IEEE Xplore	12/21/07	YH		
SPIE	12/21/07	YH		

		INTERFERENCE SEA	RCH	
Class		Subclass	Date	Examiner
382	173, 176		2/21/09	YH

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